Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/774,667	MIIDA, TAKASHI
Examiner	Art Unit
Gevell Selby	2615

		· · · · · · · · · · · · · · · · ·					
SEARCHED							
Class	Subclass	Date	Examiner				
348	294 298 300	6/3/05	65				
	301						
	308						
250	2081						
250	292	V	\ \				
			,				
			,				

	INTERFERENCE SEARCHED					
Clas	ss	Subclass	Date		Examiner	
34 (8 294 4/3/05 65		5			
		ર ૧૪			1	
		300				
		301	V		٧	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated Search	6/3/05	GS		
Inventorship search	6/3105	GS		
·				